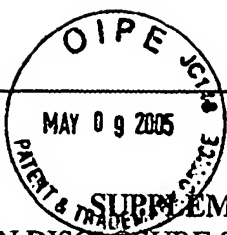


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SUPPLEMENTAL
INFORMATION DISCLOSURE STATEMENT BY APPLICANT
LIST OF ITEMS

Applicant
Peter Micha Sandvik et al.Filing Date
11/12/2003Group
2855

U.S. PATENT DOCUMENTS & U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
mc	A1	5,362,975	11/8/94	von Windheim et al.		
	A2	5,698,771	12/16/97	Shields et al.		
	A3	6,278,133	8/21/01	Harris et al.		
	A4	US2004/0112764	6/17/05	Stokes et al.		
	A5					
	A6					
	A7					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
mc	B1	DE 100 32 062	1/24/02	Germany		X
	B2					
	B3					

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, etc.)

mc	C1	J. Schalwig et al., "Gas Sensitive GaN/AlGaIn-Heterostructures", Elsevier, Sensors and Actuators, B87, pp. 425-430, 2002.
	C2	J. Schalwig et al., "Group III-Nitride-Based Gas Sensors for Combustion Monitoring", Elsevier, materials Science and Engineering, B93, pp. 207-214, 2002..
	C3	Shinji Nakagomi et al., "MISiC-FET Devices With Bias Controlled Baseline and Gas Response", IEEE International Conference on Sensors, Volume 2, pp. 1168-1173, 2003.
	C4	A. Loyd Spetz et al., "MISiCFET Sensor Arrays for On Line Diagnosis", IEEE International Conference on Sensors, Volume 2, pp. 1124-1125, 2003.
	C5	PCT International Search Report dated February 7, 2005.
	C6	

EXAMINER

DATE CONSIDERED

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